



YEA SHIN TECHNOLOGY CO., LTD

YS2302

N-Channel Enhancement MOSFET

VDS= 20V, ID= 4.9A

DESCRIPTION

The YS2302 is the highest performance trench N-Ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the small power switching and load switch applications.

The SMG2302-C meet the RoHS and Green Product requirement with full function reliability approved.

FEATURES

- Advanced High Cell Density Trench Technology
- Super Low Gate Charge
- Green Device Available

MARKING

2302

PACKAGE INFORMATION

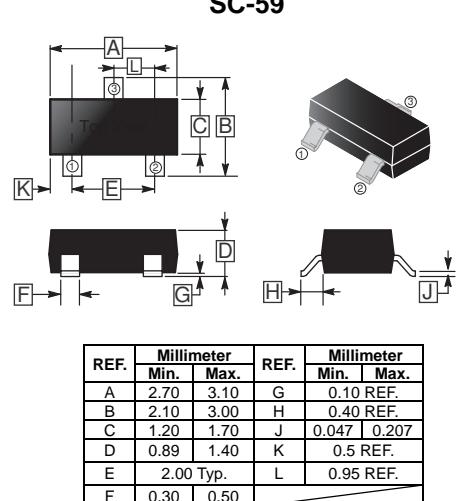
Package	MPQ	Leader Size
SC-59	3K	7 inch

ORDER INFORMATION

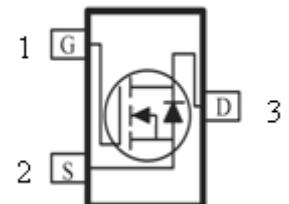
Part Number	Type
YS2302	Lead (Pb)-free and Halogen-free

ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Ratings		Unit	
		$\leq 10\text{sec}$	Steady State		
Drain-Source Voltage	V_{DS}		20	V	
Gate-Source Voltage	V_{GS}		± 12	V	
Continuous Drain Current ¹ @ $V_{GS}=4.5\text{V}$	I_D	4.9	4.2	A	
		3.8	3.3		
Pulsed Drain Current ³	I_{DM}		17	A	
Power Dissipation	P_D		1.38	W	
Operating Junction and Storage Temperature Range	T_J, T_{stg}		-55~150	°C	
Thermal Resistance Rating					
Thermal Resistance Junction-ambient ¹	$R_{\theta JA}$	$\leq 10\text{sec}, 90$		°C/W	
		Steady State, 125			
		270			
Thermal Resistance Junction-case ¹	$R_{\theta JC}$	80			



TOP VIEW



YS2302

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	20	-	-	V	$\text{V}_{\text{GS}}=0, \text{I}_D=250\mu\text{A}$
Gate-Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	0.5	-	1.2	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=250\mu\text{A}$
Forward Transconductance	g_{fs}	-	20	-	S	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=4\text{A}$
Gate-Body Leakage Current	I_{GSS}	-	-	± 100	nA	$\text{V}_{\text{GS}}= \pm 12\text{V}$
Drain-Source Leakage Current	I_{DSS}	-	-	1	μA	$\text{V}_{\text{DS}}=16\text{V}, \text{V}_{\text{GS}}=0$
		-	-	5		$\text{V}_{\text{DS}}=16\text{V}, \text{V}_{\text{GS}}=0$
Drain-Source On-Resistance ⁴	$\text{R}_{\text{DS}(\text{ON})}$	-	-	37	$\text{m}\Omega$	$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_D=3.6\text{A}$
		-	-	45		$\text{V}_{\text{GS}}=2.5\text{V}, \text{I}_D=3.1\text{A}$
Total Gate Charge	Q_g	-	8.6	-	nC	$\text{V}_{\text{DS}}=15\text{V}$
Gate-Source Charge	Q_{gs}	-	1.37	-		$\text{V}_{\text{GS}}=4.5\text{V}$
Gate-Drain Charge	Q_{gd}	-	2.3	-		$\text{I}_D=4\text{A}$
Turn-on Delay Time	$\text{T}_{\text{d}(\text{on})}$	-	5.2	-	ns	$\text{V}_{\text{DS}}=10\text{V}$ $\text{V}_{\text{GS}}=4.5\text{V}$ $\text{I}_D=4\text{A}$ $\text{R}_G=3.3\Omega$
Rise Time	T_r	-	34	-		
Turn-off Delay Time	$\text{T}_{\text{d}(\text{off})}$	-	23	-		
Fall Time	T_f	-	9.2	-		
Input Capacitance	C_{iss}	-	635	-	pF	$\text{V}_{\text{GS}}=0$ $\text{V}_{\text{DS}}=15\text{V}$ $f=1.0\text{MHz}$
Output Capacitance	C_{oss}	-	70	-		
Reverse Transfer Capacitance	C_{rss}	-	63	-		
Source-Drain Diode						
Diode Forward Voltage ⁴	V_{SD}	-	-	1.2	V	$\text{I}_S=1.6\text{A}, \text{V}_{\text{GS}}=0$
Continuous Source Current ¹	I_S	-	-	4.2	A	
Pulsed Source Current ³	I_{SM}	-	-	17	A	
Reverse Recovery Time	t_{rr}	-	7.5	-	ns	$\text{I}_F=4\text{A}, \text{dI/dt}=100\text{A}/\mu\text{s}$ $\text{T}_J=25^\circ\text{C}$
Reverse Recovery Charge	Q_{rr}	-	2.1	-	nC	

Notes:

1. Surface mounted on a 1 inch² FR-4 board with 2OZ copper.
2. When mounted on Min. copper pad.
3. Pulse width limited by maximum junction temperature.
4. The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

DEVICE CHARACTERISTICS

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CHARACTERISTIC CURVES

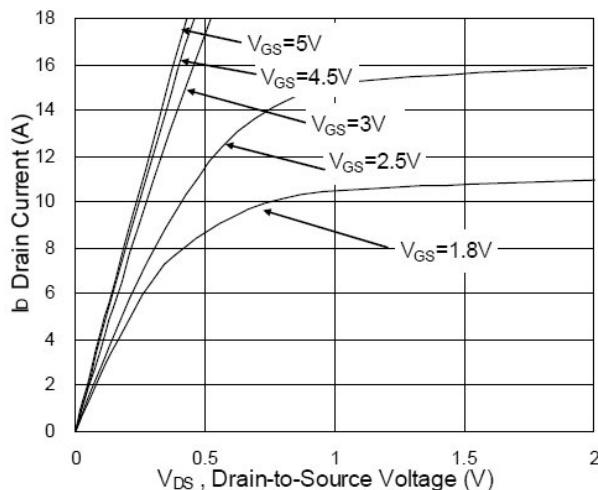


Fig.1 Typical Output Characteristics

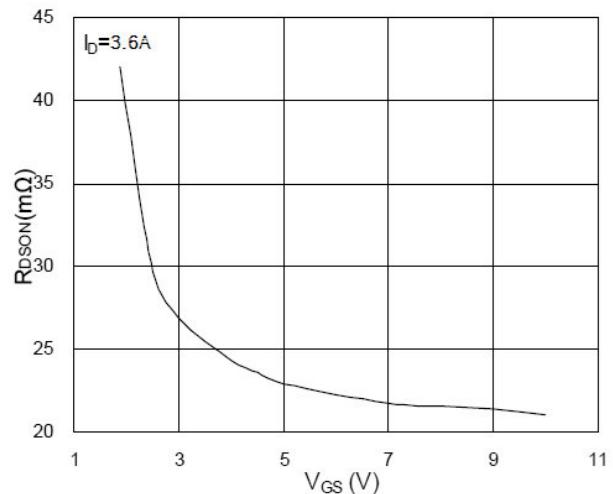


Fig.2 On-Resistance vs. Gate-Source

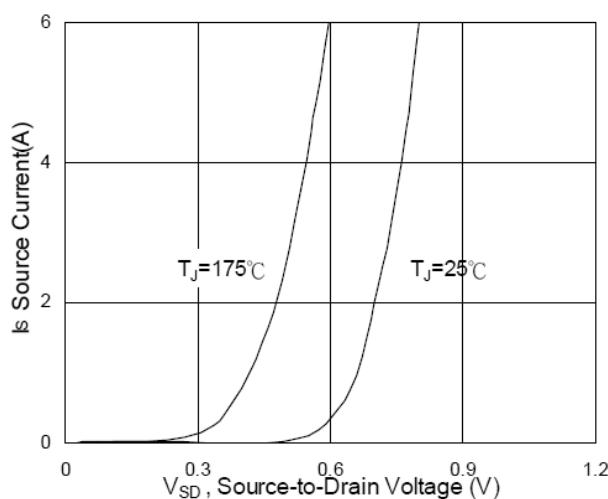


Fig.3 Forward Characteristics Of Reverse

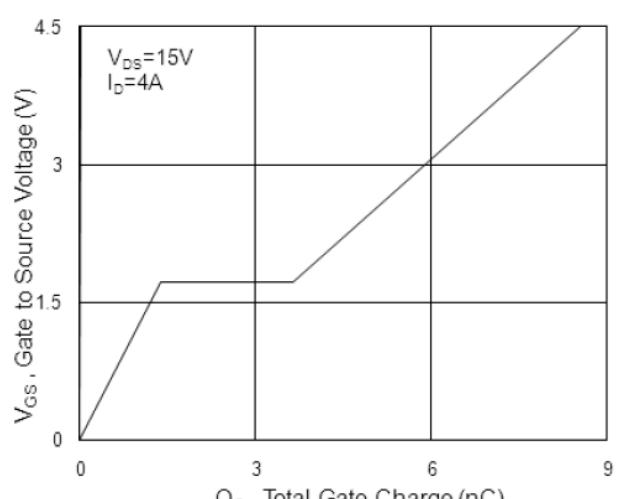


Fig.4 Gate-Charge Characteristics

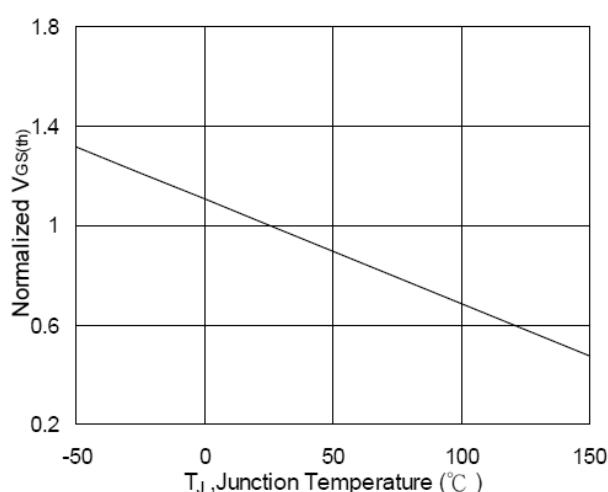


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

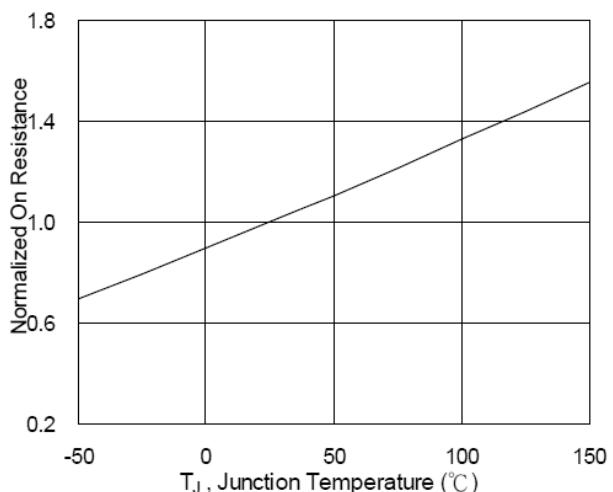


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

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CHARACTERISTIC CURVES

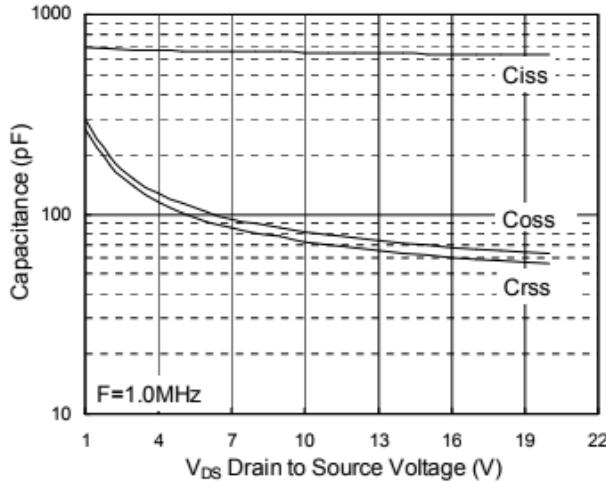


Fig.7 Capacitance

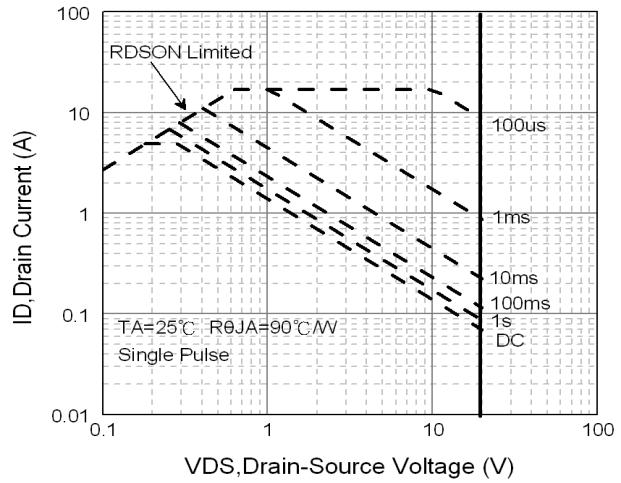


Fig.8 Safe Operating Area

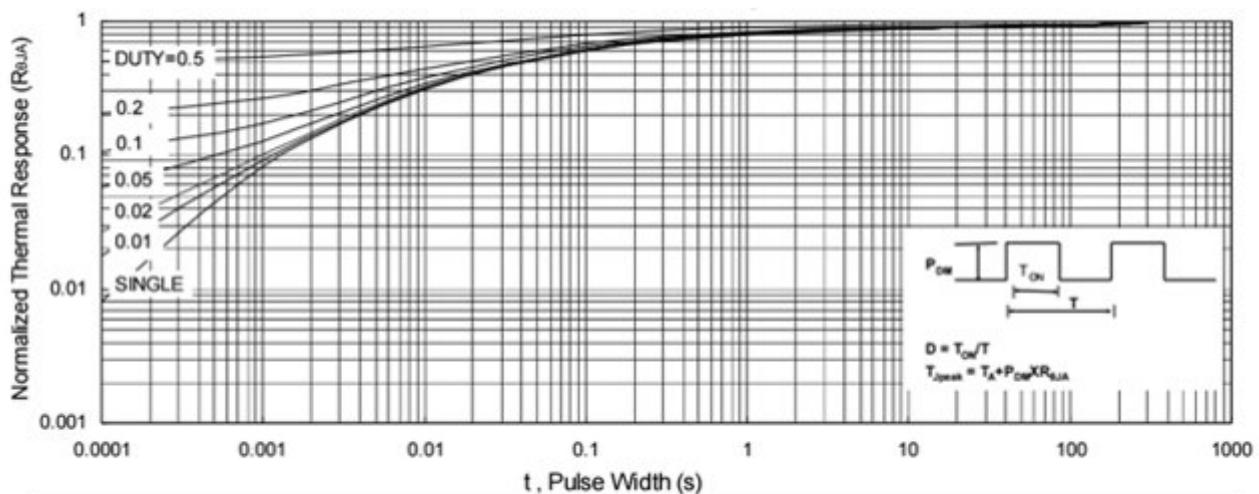


Fig.9 Normalized Maximum Transient Thermal Impedance

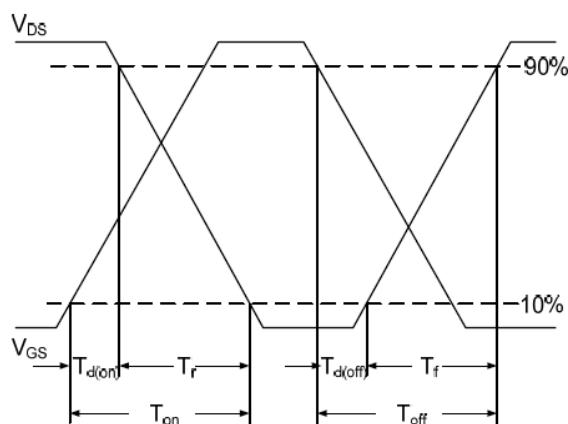


Fig.10 Switching Time Waveform

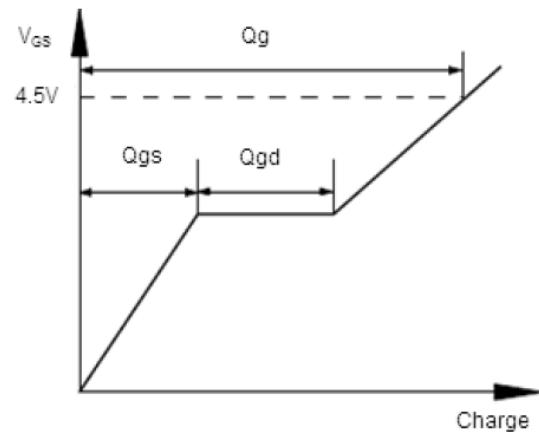


Fig.11 Gate Charge Waveform